# **Development of Transition-Edge Sensor X-ray Microcalorimeter** Linear Array for Compton Profile Measurements and Energy **Dispersive Diffraction**

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We are currently building a TES X-ray spectrometer for the Advanced Photon Source (APS) at Argonne National Laboratory (ANL) for energies less than 20 keV in collaboration with National Institute of Standards and Technology (NIST). The spectrometer consists of application specific TES sensors for pilot XAFS and XES experiments. We propose to develop and fabricate these TES sensors for the very hard X-ray energy range (20-100 keV). We have recently published an article where we present a design optimization for a linear TES array for energy-dispersive X-ray diffraction and Compton profile measurements [1]. We present our progress on simulation results, preliminary sensor layouts, and proof-of-principle fabrication of millimeter long SiN membranes.

## Introduction

Energy Dispersive X-Ray Diffraction (EDXRD)

The sample diffraction pattern is measured at a fixed angle by using polychromatic photons and an energydispersive detector.

- $\succ$  Compared to angle-dispersive XRD, it does not need sample rotation;
- > When a detector with spatial resolution is used, multiple parts of the sample can be measured at the same time;
- $\succ$  The d-spacing resolution is limited by the energy resolution of the detector.

### Compton scattering

Current high-resolution Compton scattering experiments are done with crystal spectrometers.



Setup of the EDXRD. Rumaiz, A. K. et al. IEEE Transactions on *Nuclear Science* **61**, 3721–3726 (2014).

# $p_{z} = mc \frac{\omega_{2} - \omega_{1} + \omega_{1}\omega_{2} (1 - \cos\theta)/mc^{2}}{(\omega_{1}^{2} + \omega_{2}^{2} - 2\omega_{1}\omega_{2}\cos\theta)^{1/2}}$

θ: photon scattering angle  $p_{z}$  : electron momentum

## Fabrication and Characterization

### Sensor layout

### Fabrication of prototype devices

- Each fab run with 8 mask process
- ➢ Each 3-inch wafer contains 24 dies, with 20 devices each
- > Each die explores different aspects of the device design:  $T_{C}$  and  $\alpha$ , G and C
- > Use of standard sapphire carrier in Plasmatherm DRIE tool results in complete etch stop of Si due to lower bias seen by substrate.
- > Need of mounting bonded wafer stack on Si carrier.





### $\omega_1$ : incident photon energy $\omega_2$ : scattered photon energy

Both experiments require  $\Delta E < 80 \text{ eV}$  @100keV

# **Design Optimization**

The TES detector offers good energy resolution. The linear array design provides spatial resolution.



> Need of development of low power slower DRIE etch recipes for reduced heat generation



### $\succ$ Plating area density = 6.44 %

 $\geq$  ~ 1 µm plating in TechniGold 25E and ~ 9 µm in Neutronex bath

### **Results and discussions**



> Thermal conductance G nearly independent of absorber length suggesting heat flow to the cold bath is dominated by membrane geometry rather than by the absorber area



### TES strip array: ANL fab run v1.0





 $G_{total} = 2000 \text{ pW/K}, L = 700 \text{ nH}, T_b=100 \text{ mK}$ 

### **ΔE ~ 21 eV**

Meets experimental needs

#### References:

(1) D. Yan et al; Modelling a Transition-Edge Sensor X-ray Microcalorimeter Linear Array for Compton Profile Measurements and Energy Dispersive Diffraction, (2019) https://arxiv.org/abs/1902.10047.

(2) Rumaiz, A. K. et al. A Monolithic Segmented Germanium Detector with Highly Integrated Readout. IEEE Transactions on Nuclear Science 61, 3721–3726 (2014).

(3) Hiraoka, N. et al. A new X-ray spectrometer for high-resolution Compton profile measurements at SPring-8. J Synchrotron Rad 8, 26–32 (2001).



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> Linear relationship of 1/average pulse height, and pulse decay time with absorber length

> Demonstrated minimal unwanted effect of long strip geometry on X-ray pulse response

### Future Work :

 $\geq$  Plan to fabricate next generation devices with a target absorber thickness (20  $\mu$ m Au + 30  $\mu$ m Bi) and study energy resolution, quantify effect of position dependence

